

SANYO Semiconductors DATA SHEET

2SC6082 — 50V / 15A High-Speed Switching Applications

Applications

· High-speed switching applications (switching regulator, driver circuit).

Features

- · Adoption of MBIT process.
- · Large current capacitance.
- · Low collector-to-emitter saturation voltage.
- · High-speed switching.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	VCBO		60	V
Collector-to-Emitter Voltage	VCES		60	V
Collector-to-Emitter Voltage	VCEO		50	V
Emitter-to-Base Voltage	VEBO		6	V
Collector Current	IC		15	Α
Collector Current (Pulse)	ICP	PW≤10μs, duty cycle≤10%	20	Α
Base Current	IΒ		3	А
Collector Dissipation	D-		2	W
	PC	Tc=25°C	25	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector Cutoff Current	ICBO	V _{CB} =40V, I _E =0A			10	μΑ
Emitter Cutoff Current	IEBO	VEB=4V, IC=0A			10	μΑ
DC Current Gain	hFE1	V _{CE} =2V, I _C =330mA	200		560	
	hFE2	V _{CE} =2V, I _C =10A	50			

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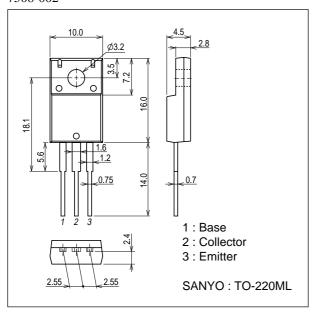
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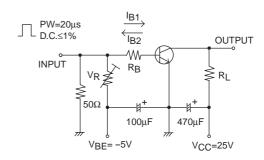
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Gain-Bandwidth Product	fT	V _{CE} =10V, I _C =2A		195		MHz
Output Capacitance	Cob	V _{CB} =10V, f=1MHz		85		pF
Collector-to-Emitter Saturation Voltage	VCE(sat)	IC=7.5A, IB=375mA		200	400	mV
Base-to-Emitter Saturation Voltage	VBE(sat)	IC=7.5A, IB=375mA			1.2	V
Collector-to-Base Breakdown Voltage	V(BR)CBO	I _C =100μA, I _E =0A	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CES	IC=100μA, RBE=0Ω	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	IC=1mA, RBE=∞	50			V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	I _E =100μA, I _C =0A	6			V
Turn-ON Time	ton	See specified Test Circuit.		52		ns
Storage Time	tstg	See specified Test Circuit.		560		ns
Fall Time	t _f	See specified Test Circuit.		37	·	ns

Package Dimensions

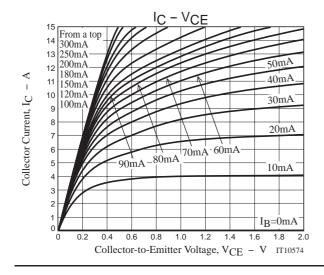
unit : mm 7508-002

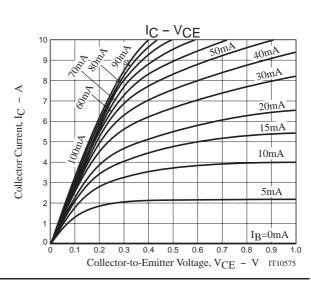


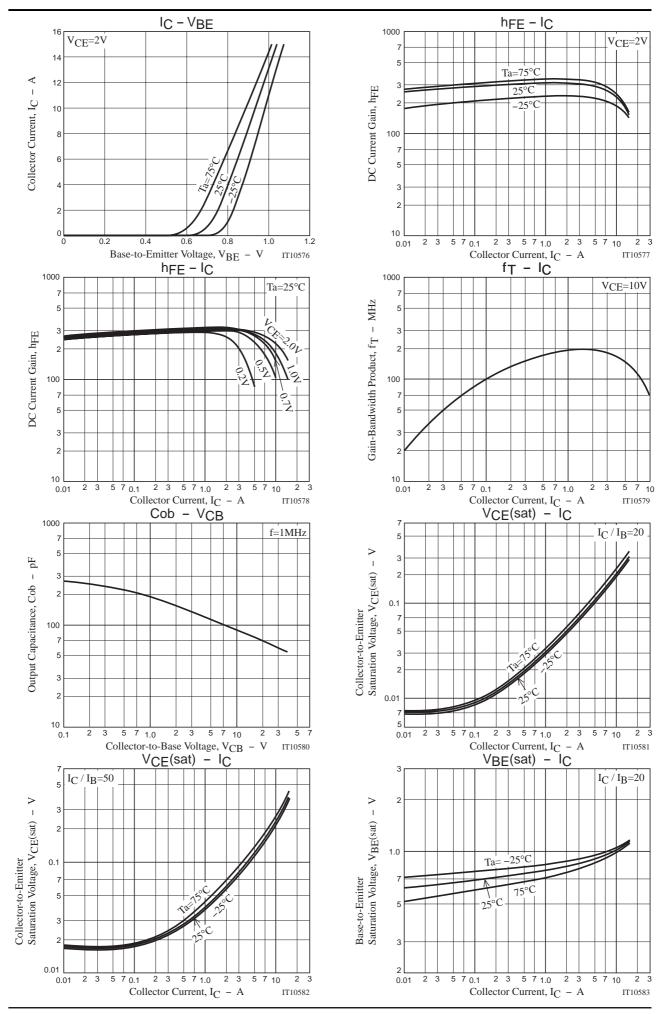
Switching Time Test Circuit

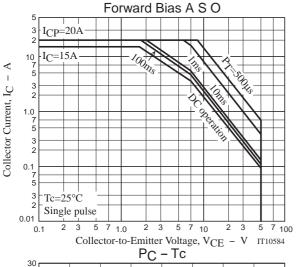


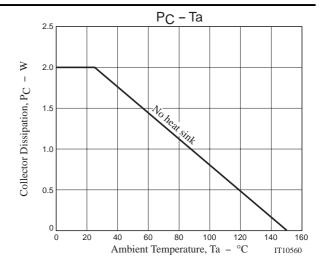
$$I_{C}=20I_{B1}=-20I_{B2}=5A$$

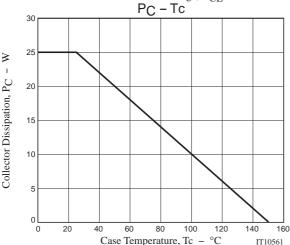












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